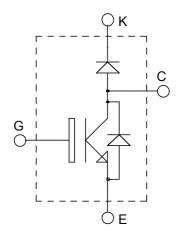


ISOTOP[®] Boost chopper NPT IGBT

$V_{CES} = 600V$ $I_{C} = 60A$ @ Tc = 95°C





Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction
- Brake switch

Features

- Non Punch Through (NPT) THUNDERBOLT IGBT
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 100 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - Avalanche energy rated
 - RBSOA and SCSOA rated
- ISOTOP[®] Package (SOT-227)
- Very low stray inductance
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T_C of V_{CEsat}
- RoHS Compliant

Absolute maximum ratings

Symbol	Parameter			Max ratings	Unit
V _{CES}	Collector - Emitter Breakdown Voltage			600	V
I _{C1}	Continuous Collector Current $\frac{T_{C} = 25^{\circ}C}{T_{C} = 95^{\circ}C}$		93		
I _{C2}			$T_C = 95^{\circ}C$	60	А
I _{CM}	Pulsed Collector Current		$T_C = 25^{\circ}C$	360	
V _{GE}	Gate – Emitter Voltage			±20	V
P _D	Maximum Power Dissipation $T_C = 25^{\circ}$		$T_C = 25^{\circ}C$	378	W
I _{LM}	RBSOA clamped Inductive load Current $R_G=11\Omega$		$T_C = 25^{\circ}C$	360	А
IF _{AV}	Maximum Average Forward Current	Duty cycle=0.5	$T_C = 80^{\circ}C$	30	А
IF _{RMS}	RMS Forward Current (Square wave, 50% duty)			39	Л

💱 🚓 UTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

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All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I _{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25^{\circ}C$			80	μA
		$V_{CE} = 600 V$	$T_j = 125^{\circ}C$			2000	
V _{CE(sat)}	Collector Emitter saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		2.0	2.5	V
		$I_C = 60A$ $T_j =$	$T_{j} = 125^{\circ}C$			2.8	v
V _{GE(th)}	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 500 \mu A$		3	4	5	V
I _{GES}	Gate – Emitter Leakage Current	$V_{GE} = \pm 20V, V_{CE} = 0V$				±100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		3125	3590	
Coes	Output Capacitance	$V_{CE} = 25V$		310	450	pF
C _{res}	Reverse Transfer Capacitance	f = 1 MHz		180	310	
Qg	Total gate Charge	$V_{GS} = 15V$		257	410	
Q _{ge}	Gate – Emitter Charge	$V_{Bus} = 300V$		19	30	nC
Q _{gc}	Gate – Collector Charge	$I_C = 60A$		120	180	
T _{d(on)}	Turn-on Delay Time	Resistive Switching (25°C)		20	40	
Tr	Rise Time	$V_{GE} = 15V$ $V_{GE} = 200V$		95	190	n 0
T _{d(off)}	Turn-off Delay Time	$\frac{V_{Bus} = 300V}{I_C = 60A}$		315	470	ns
T _f	Fall Time	$R_G = 5\Omega$		245	490	
T _{d(on)}	Turn-on Delay Time	Inductive Switching (25°C)		26	50	
Tr	Rise Time	$V_{GE} = 15V$		63	125	
T _{d(off)}	Turn-off Delay Time	$V_{Bus} = 400V$ $I_C = 60A$		395	590	ns
T _f	Fall Time	$\frac{I_{\rm C} - 60 \text{A}}{R_{\rm G} = 5\Omega}$		68	140	1
Ets	Total switching Losses			3.4	7	mJ
T _{d(on)}	Turn-on Delay Time	Inductive Switching (150°C)		25	50	
T _r	Rise Time	$V_{GE} = 15V$		59	120	
T _{d(off)}	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 60A$		430	650	ns
T _f	Fall Time	$\frac{I_{\rm C} - 60A}{R_{\rm G} = 5\Omega}$		65	130	
Eon	Turn-on Switching Energy			1.6	3.2	
E _{off}	Turn-off Switching Energy			2.4	4.8	mJ
E _{ts}	Total switching Losses			4.0	8.0	



Chopper diode ratings and characteristics

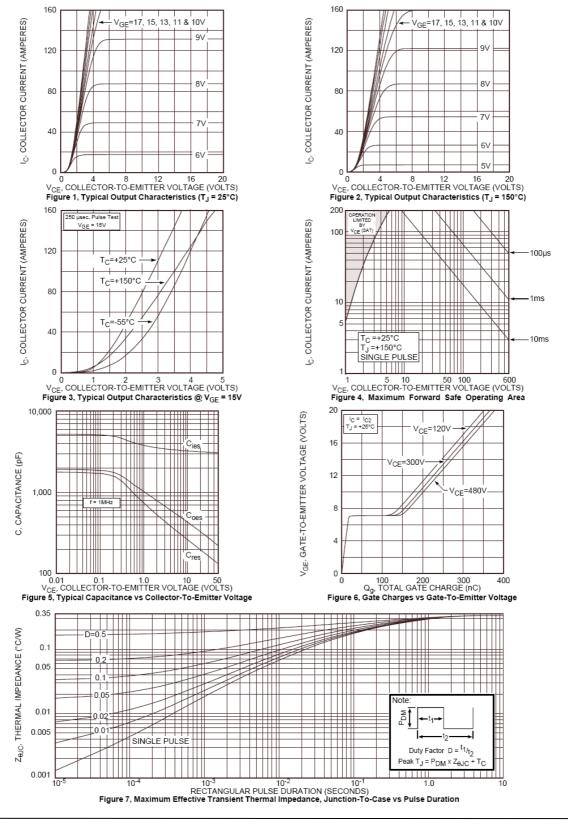
Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
	Diode Forward Voltage	$I_F = 30A$			1.6	1.8	
$V_{\rm F}$		$I_F = 60A$			1.9		V
		$I_F = 30A$	$T_{i} = 125^{\circ}C$		1.4		
I _{RM}	Maximum Reverse Leakage Current	$V_{R} = 600 V$	$T_j = 25^{\circ}C$			250	μA
IRM		$V_{R} = 600 V$	$T_{j} = 125^{\circ}C$			500	μΛ
CT	Junction Capacitance	$V_{R} = 200 V$			44		pF
4	Reverse Recovery Time	$I_F=1A, V_R=30V$ di/dt =100A/µs	$T_j = 25^{\circ}C$		23		
t _{rr}	Reverse Recovery Time	$T_i = 25^{\circ}C$ $T_i = 125^{\circ}C$	$T_i = 25^{\circ}C$		85		ns
				160			
I _{RRM}	$I_F = 30A$	$T_j = 25^{\circ}C$		4		А	
IRRM	Maximum Reverse Recovery Current	$V_{\rm R} = 400 V$	$T_{i} = 125^{\circ}C$		8		Л
0	Paulana Pagayany Changa	$di/dt = 200 A/\mu s$	$T_j = 25^{\circ}C$		130		nC
Q _{rr}	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		700		IIC
t _{rr}	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 1000A/\mu s$			70		ns
Q _{rr}	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		1300		nC
I _{RRM}	Maximum Reverse Recovery Current				30		Α

Thermal and package characteristics

Symbol	Characteristic		Min	Тур	Max	Unit	
R _{thJC}	Junction to Case Thermal Resistance	IGBT			0.33		
		Diode			1.21	°C/W	
R _{thJA}	Junction to Ambient (IGBT & Diode)				20		
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz		2500			V	
T_J, T_{STG}	Storage Temperature Range		-55		150	°C	
T _L	Max Lead Temp for Soldering:0.063" from case for 10 sec				300	- C	
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m	
Wt	Package Weight			29.2		g	



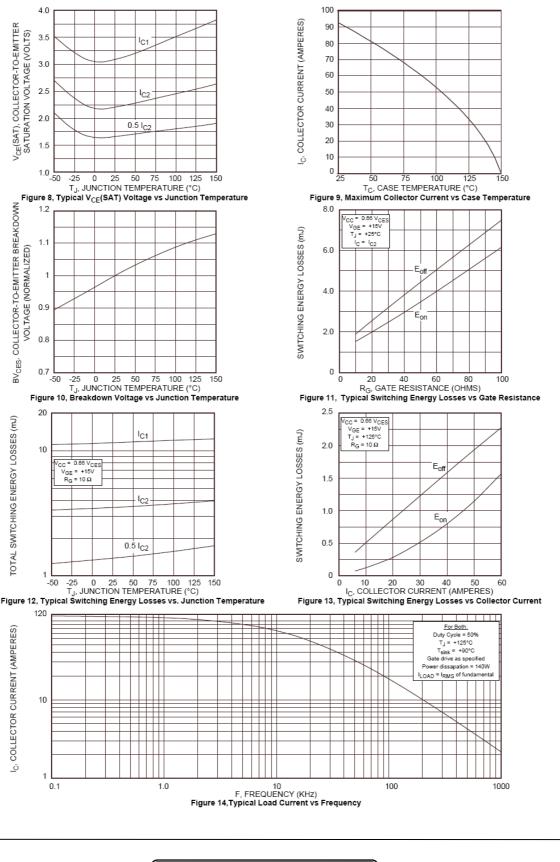
Typical IGBT Performance Curve



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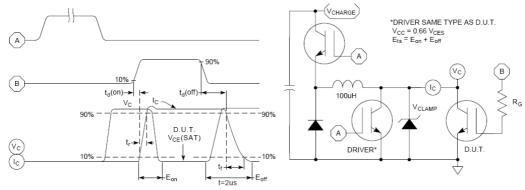


Figure 15, Switching Loss Test Circuit and Waveforms

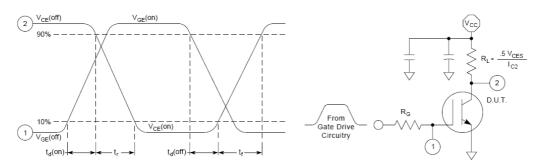
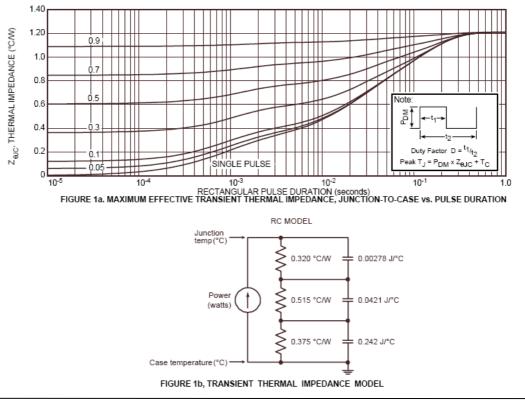


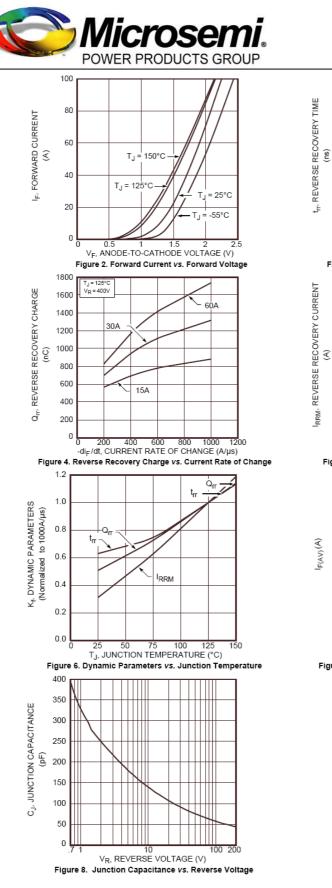
Figure 16, Resistive Switching Time Test Circuit and Waveforms

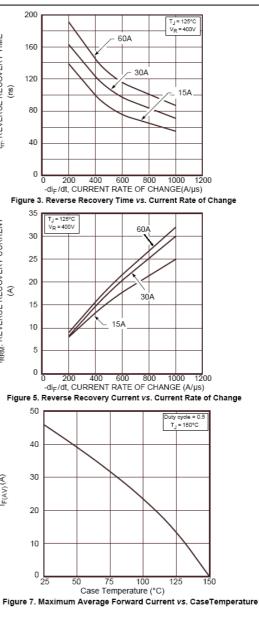


Typical Diode Performance Curve

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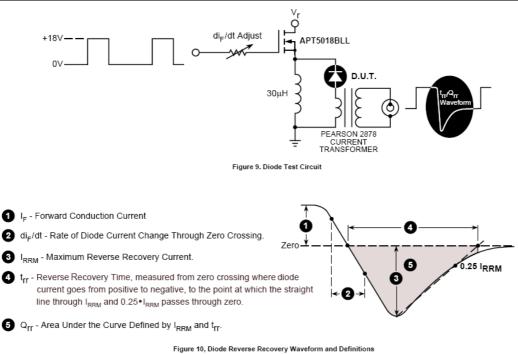




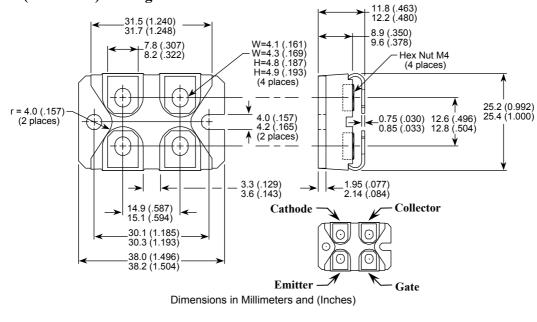
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SOT-227 (ISOTOP[®]) Package Outline



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